Se	arcn Notes	
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Application/Control No.	Applicant(s)/Patent under Reexamination
10/068,254	VALE ET AL.
Examiner	Art Unit
Kelly L. Jerabek	2622

	SEAR	CHED	
Class	Subclass	Date	Examiner
348	207.1	12/11/2006	KJ
	208.15		
	208.99		
	231.9	12/12/2006	

INI	ERFERENC	E SEARCH	ED
Class	Subclass	Date	Examiner
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SEARCH NO (INCLUDING SEARCH		<u> </u>
	DATE	EXMR
IEEE	12/11/2006	KJ
EAST Keyword	12/12/2006	
Tuan Ho	8/9/2006	
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